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Diode and Final-Focus Simulations for DARHT

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Abstract

Beam dynamics calculations for the injector and final-focus region of a 4 kA, 20 MeV linear induction accelerator are presented. The injector is a low-emittance 4 MeV thermionic or photocathode diode designed to produce four 70 ns pulses over 2 μ sec. Due to the long total pulse length, we have kept the field stress to < 200 kV/cm over the cathode electrode, and to ≈ 50 kV/cm on the radial insulator stacks. The normalized edge emittance produced by the diode is only ≈ 0.019 cm-rad. In the final-focus region, we have modelled the effect of ion emission from the target. The intense electric field of the beam at the 1-mm-diameter focal spot produces substantial ion velocities, and, if the space-charge-limited current density can be supplied, significant focal spot degradation may occur due to ion space-charge. Calculations for the existing Integrated Test Stand, which has a larger focal spot, show that the effect should be observable for H^+ and C^+ ion species. The effect is lessened if there is insufficient ion density on the target to supply the space-charge-limited current density, or if the ion charge-to-mass ratio is sufficiently small.

1 INTRODUCTION

The Dual-Axis Radiographic Hydrodynamics Test Facility (DARHT) will use tightly-focused electron beams to create large X-ray doses with a time-integrated spot-size on the order of 1 mm [1, 2]. The first axis of DARHT, currently under construction at Los Alamos National Laboratory, is a nominally 20 MeV, 4 kA linear induction accelerator providing a single pulse with a 60 ns flat-top. One proposal for the second axis of the facility is to generate up to four pulses over a period of 2 μ sec [3]. We have designed a low-emittance thermionic injector, described in Sec. 2, for the second axis. The diode provides 4 kA at 4 MeV. The beam has been transported through the first 8 induction accelerating gaps, demonstrating that the low emittance is preserved over that distance.

At the other end of the accelerator, the beam is focused onto an X-ray converter to produce a spot with a diameter of about 1 mm. Numerical simulations presented in Sec. 3 show that if the target becomes a space-charge-limited source of light ions, then significant disruption of the focal spot is possible as the ions move upstream. We have calculated the effect for an existing 3.85 kA, 5.5 MeV prototype for DARHT, the Integrated Test Stand (ITS) [1, 2], and find that the effect should be observable.

2 LOW-EMITTANCE 4 KA INJECTOR

The injector we have designed to produce four discrete pulses for DARHT is based on the present ITS injector [4, 5]. The latter is a 4 MeV, 4 kA diode with a flat velvet cathode set in a flat electrode. The pulse has excellent voltage and current flatness, and reproducibility. The beam emittance is dominated by the thermal emittance introduced at the emission surface, and has been measured to be ≈ 0.16 cm-rad (normalized Lapostolle edge emittance). For the 4-pulse injector, we have modified the design in order to reduce electrode field stresses (since the stresses are applied for a longer time), and also to take advantage of a low-emittance thermionic- or photo-cathode. The injector layout is shown in Fig. 1. Metglas cores, 10 on one side and

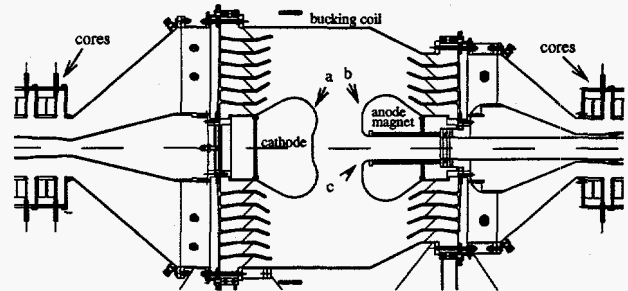


Figure 1: Layout of 4-pulse injector. The field stresses (kV/cm) with (without) the beam at the points marked are: (a) 184 (187), (b) 161 (157) (c) 185 (159).

6 on the other, each provide about 0.25 MeV of inductive voltage, summing to 4 MeV across the AK gap. A Pierce-like electrode surrounding the emission area replaces the flat electrode on the ITS injector because (a) it keeps the current density at the cathode surface below 20 A/cm² (a reasonable number for a thermionic emitter) and (b) edge effects which contribute to the beam emittance in the ITS are reduced. The AK gap, defined as the distance from the emission surface to the nearest plane intersecting the anode, is 33.7 cm. The emission-surface radius is 8.9 cm and the radius-of-curvature of the cathode shroud is 16.25 cm.

Using the PBGUNS [6] code, we calculated the field stresses along the cathode and anode electrodes. The maximum values are given in Fig. 1. These values are lower than those for the ITS injector by factors of 0.6–0.7 and are in line with commonly used scaling laws for breakdown as a function of pulse length.

To model the detailed optics of the diode, we used the particle-in-cell code IVORY. Results are shown in Fig. 2. The simulation is carried out with a mesh size ($\Delta z, \Delta r$)

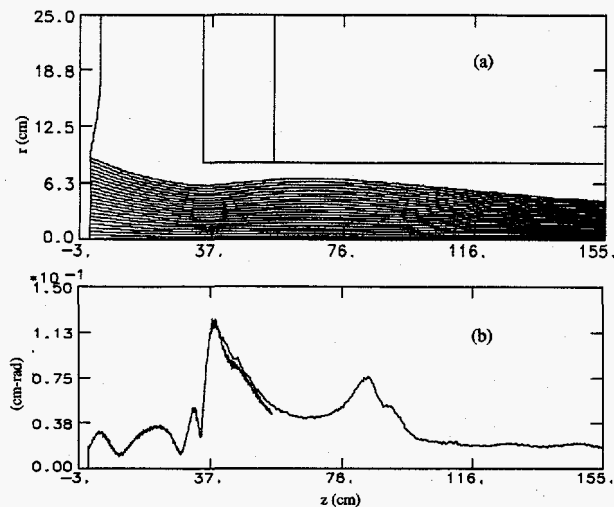


Figure 2: Simulation of 4 MeV, 4 kA diode in Fig. 2 using IVORY showing (a) particle positions and (b) normalized edge emittance vs. z .

of (1 mm, 1 mm) in the AK gap region, transitioning to (4 mm, 2 mm) downstream. A cathode temperature of 0.1 eV, typical of thermionic emitters, is assumed. The normalized edge emittance as a function of z is shown in Fig. 2(b). The variation of emittance through the AK gap and focusing magnet due to nonlinear self and external fields, has previously been studied [7]. The emittance settles to a reasonably constant value of 0.019 cm-rad downstream of the anode magnet. Unlike the ITS beam, this value is dominated by optical effects rather than by the cathode temperature.

To transport the beam further downstream, we use the single-slice code SPROP. This code solves Maxwell's equations on a radial mesh assuming $\partial/\partial z \equiv 0$. It includes the diamagnetic field generated by beam rotation, and the inductive axial self-electric field gives the correct kinetic-energy variation of a converging or diverging beam. SPROP is initialized at $z = 145.2$ cm with a slice of beam particles from IVORY. To control the beam between the anode magnet and the first cell, we have placed two solenoids between the anode magnet and the first induction-cell magnet. Adjusting these magnets and the first eight cell magnets gives us the beam edge radius and emittance shown in Fig. 3, where we have plotted both the IVORY diode results and the SPROP downstream results. We see that the emittance remains reasonably constant at about 0.019 cm-rad over the ≈ 7 meter distance.

3 EFFECT OF ION EMISSION FROM TARGET

The high space-charge density at the DARHT X-ray converter target gives rise to a large axial electric field (on the order of 4 MeV/cm). There is strong experimental evidence [8, 9] that anode plasmas are formed when loosely-bound surface layers (typically hydrocarbons) are heated to

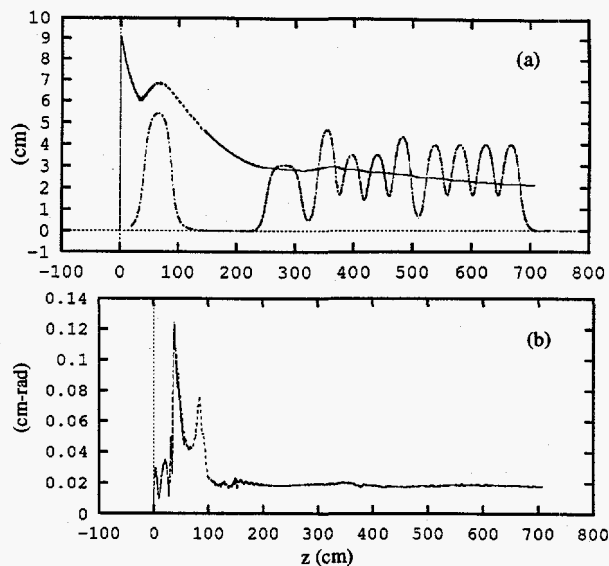


Figure 3: (a) Beam edge radius with overlay of axial magnetic field and (b) normalized emittance from the injector through the first eight cell magnets.

on the order of 400^o C. The layers evaporate off the surface and are ionized by the electron beam, providing a source of positive ions which are accelerated into the beam by the axial electric field. Sanford *et al.* [8] found evidence of several A/Z (atomic weight/charge state) ratios in the measured ion flux.

To study the effect of ion emission, we carried out simulations with the IPROP code using typical DARHT parameters: $\gamma = 40$ (≈ 20 MeV), a current of 4 kA, and a normalized edge emittance of 0.1 cm-rad. As shown in Fig. 4, the beam is injected from the open left boundary with a radially inward velocity such that it focuses to a minimum at the conducting right boundary. We assume a space-charge-limited source of a given ion species from regions of the right boundary which are heated to 400^o C.

For the case of protons, the beam radius near the target surface is plotted as a function of time in Fig. 5. The run was stopped soon after ions reached the left boundary. We see that there is a large effect after just a few nanoseconds. The electron and ion positions after 6.7 ns are shown in Fig. 4. At this time the protons are moving upstream with a velocity on the order of 0.03c (0.9 cm/ns). The line charge-density of the ions is on the order of 10% of the beam line density, which produces a large radial focusing force on the beam. Initially, the ions cause a decrease in the focal spot, but as they move upstream against the beam, they cause the beam to overfocus.

The calculation was repeated with space-charge-limited emission of singly-ionized tungsten ($A/Z = 184$), giving the RMS radius shown in Fig. 5. The timescale for development of beam pinching increases roughly as the square root of the mass ratio, i.e., a factor ≈ 13 .

The ITS prototype for DARHT [1, 2] may allow the ef-

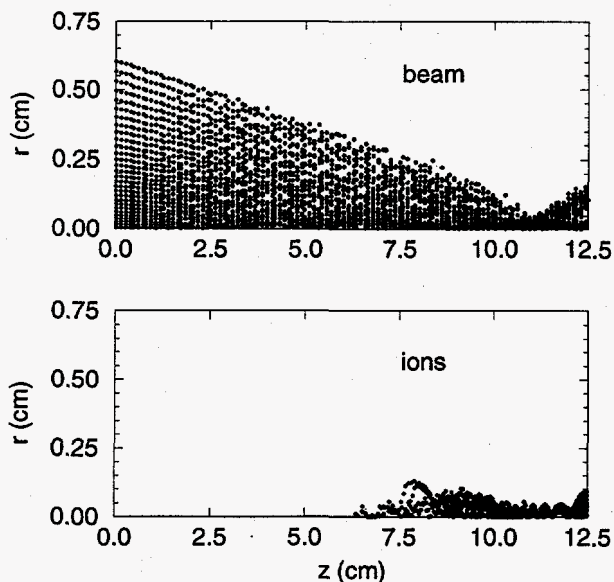


Figure 4: Simulation of space-charge-limited proton emission from target using IPROP. Beam and proton positions are shown after 6.7 ns.

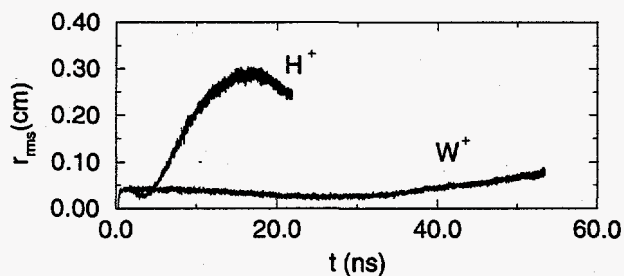


Figure 5: Beam RMS radius near target surface as a function of time for nominal DARHT parameters, with space-charge-limited emission of H^+ and W^+ (singly-ionized tungsten) from target.

fects of target ions to be studied before the DARHT beam is available. The 3.85 kA, 5.5 MeV beam has a normalized edge emittance of ≈ 0.16 cm-rad. We have carried out simulations with typical ITS final-focus parameters for two species: H^+ and C^+ . The focal spot behavior is shown in Fig. 6. Comparing the H^+ case with that for DARHT parameters (Fig. 5), we see that because the beam is larger, it takes considerably longer for the ions to have an effect on the beam spot. Nevertheless for both H^+ and C^+ there is a large change in the focal spot during a 60 ns pulse which should be observable with streak-camera diagnostics.

The principal uncertainty in applying these results to experiments is due to the fact that it is difficult to predict the type and abundance of ions produced at the target. Existing streak-camera data [10] from ITS with parameters comparable to those used to obtain Fig. 6 show considerably less variation in radius. Further experiments are currently un-

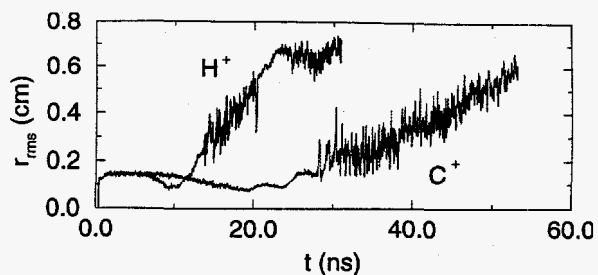


Figure 6: Beam RMS radius near target for ITS parameters with space-charge-limited emission of H^+ and C^+ ions from the target.

derway at the ITS and other machines to study the phenomenon in detail [10, 11].

Several schemes have been proposed to mitigate the effects of ion emission, including cleaning to remove surface deposits, placing the target in a low-pressure gas cell, and electrically biasing the target. We will await the results of target experiments currently under way before carrying out detailed evaluation of these options.

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